

# N-Channel 20V (D-S) MOSFET

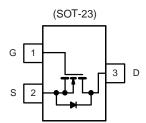
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a, g</sup>	Q <sub>g</sub> (Typ.)		
20	0.015 at V <sub>GS</sub> = 4.5V	8	10nC		
20	0.018 at V <sub>GS</sub> = 2.5V	7	TUNC		

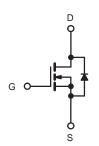
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Gen III Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC









N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	<b>IGS</b> T <sub>A</sub> = 25 °C,	unless otherwi	ise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage		$V_{GS}$	± 12	v	
	T <sub>C</sub> = 25 °C		8 <sup>a, g</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	I <sub>D</sub>	5.5 <sup>g</sup>		
Continuous Diam Current (1) = 130 C)	T <sub>A</sub> = 25 °C	'D	6 <sup>b, c</sup>	A	
	T <sub>A</sub> = 70 °C		3.5 <sup>b, c</sup>	^	
Pulsed Drain Current		I <sub>DM</sub>	30 <sup>g</sup>		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	14		
Avalanche Energy		E <sub>AS</sub>	11.25	mJ	
Continuous Source-Drain Diode Current	Source-Drain Diode Current   V	3 <sup>a, g</sup>	А		
Continuous Source-Diam Diode Current		'S	1.5 <sup>b, c</sup>	^	
	T <sub>C</sub> = 25 °C		3.2		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.8	W	
Maximum i Owei Dissipation	T <sub>A</sub> = 25 °C	' D	2.2 <sup>b, c</sup>	• • • • • • • • • • • • • • • • • • • •	
	T <sub>A</sub> = 70 °C		1.0 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		_	260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	29	36	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	3.6	4.5			

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 81 °C/W.
- g. Package limited.



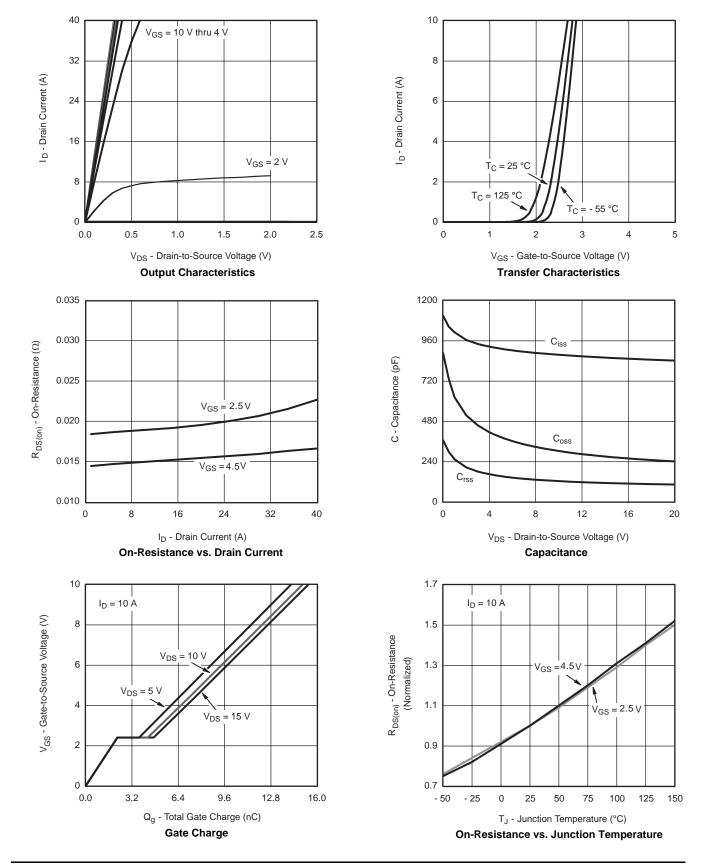
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		22		\//00
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.0		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	0.5		1.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Oata Waltana Busin Oamani	,	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	12			Α
Drain-Source On-State Resistance <sup>a</sup>		$V_{GS} = 4.5V, I_{D} = 10 \text{ A}$		0.015		
	R <sub>DS(on)</sub>	$V_{GS} = 2.5V$ , $I_{D} = 7 A$		0.018		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A		26		S
Dynamic <sup>b</sup>			l		l	<u>I</u>
Input Capacitance	C <sub>iss</sub>			865		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		316		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			131		
Tatal Oata Obanna	0	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		15	23	
Total Gate Charge	Q <sub>g</sub>		10			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.5		nC
Gate-Drain Charge	$Q_{gd}$			2.3		
Gate Resistance	$R_g$	f = 1 MHz	0.2	0.9	1.8	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	30	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 2 $\Omega$		11	22	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 5$ A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		16	30	
Fall Time	t <sub>f</sub>			8	16	
Turn-On Delay Time	t <sub>d(on)</sub>			10	20	ns -
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 2 $\Omega$		8	16	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 5$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		16	30	
Fall Time	t <sub>f</sub>			7	14	
<b>Drain-Source Body Diode Characteristi</b>	cs		I.		I.	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		8		۸
Pulse Diode Forward Current	I <sub>SM</sub>			30		Α
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A, V <sub>GS</sub> = 0 V		0.77	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			14	28	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/v; T = 05 °C		4.5	9	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		5.5		
Reverse Recovery Rise Time	t <sub>b</sub>	$\dashv$		8.5		ns

#### Notes:

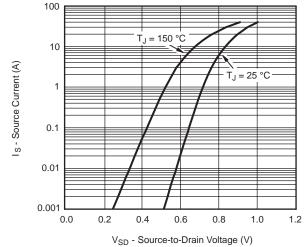
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

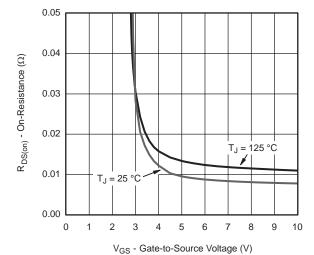




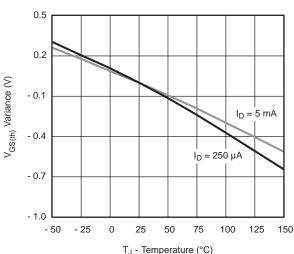




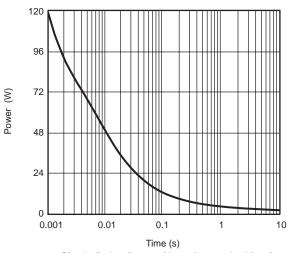
Source-Drain Diode Forward Voltage



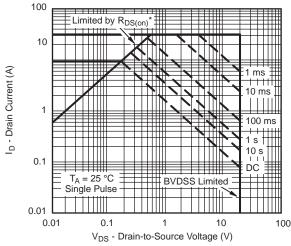
On-Resistance vs. Gate-to-Source Voltage



T<sub>J</sub> - Temperature (°C)
Threshold Voltage



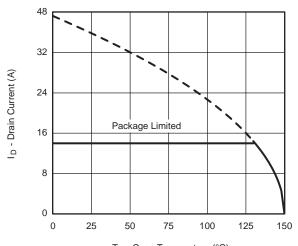
Single Pulse Power (Junction-to-Ambient)



\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

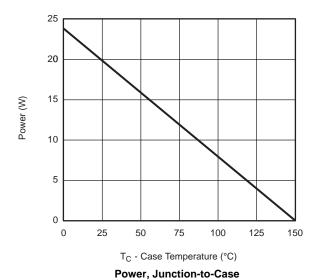
Safe Operating Area, Junction-to-Ambient

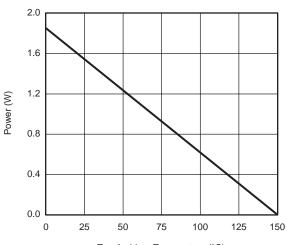




T<sub>C</sub> - Case Temperature (°C)

## **Current Derating\***



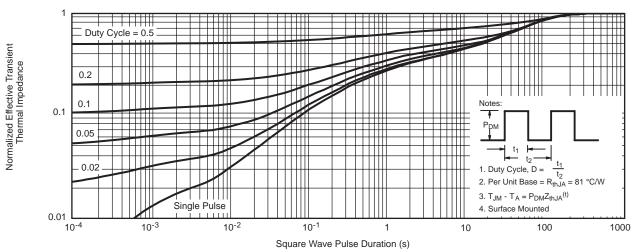


T<sub>A</sub> - Ambient Temperature (°C)

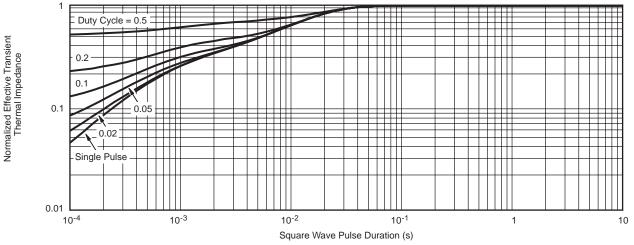
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





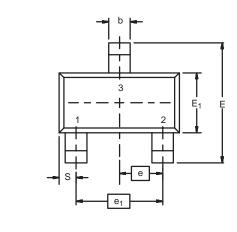
Normalized Thermal Transient Impedance, Junction-to-Ambient

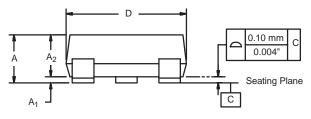


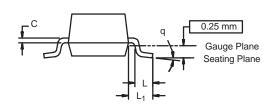
Normalized Thermal Transient Impedance, Junction-to-Case



### **SOT-23: 3-LEAD**







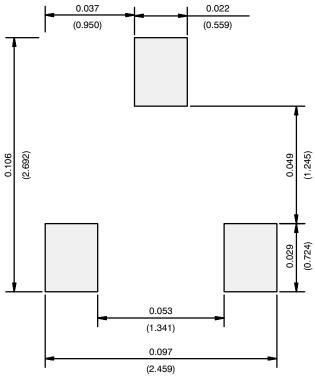
Dim -	MILLIMETERS		INCHES	
	Min	Max	Min	Max
Α	0.89	1.12	0.035	0.044
A <sub>1</sub>	0.01	0.10	0.0004	0.004
A <sub>2</sub>	0.88	1.02	0.0346	0.040
b	0.35	0.50	0.014	0.020
С	0.085	0.18	0.003	0.007
D	2.80	3.04	0.110	0.120
E	2.10	2.64	0.083	0.104
E <sub>1</sub>	1.20	1.40	0.047	0.055
е	0.95 BSC		0.037	4 Ref
e <sub>1</sub>	1.90 BSC		0.074	8 Ref
L	0.40	0.60	0.016	0.024
L <sub>1</sub>	0.64 Ref		0.025	5 Ref
S	0.50 Ref		0.020	) Ref
q	3°	8°	3°	8°

ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479



### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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